

Title (en)

NANO-POROUS METAL OXIDE SEMICONDUCTOR SPECTRALLY SENSITIZED WITH METAL CHALCOGENIDE NANO-PARTICLES

Title (de)

SPEKTRAL MIT METALLKALKOGENIDNANOPARTIKELN SENSIBILISIERTER NANOPORÖSER METALLOXIDHALBLEITER

Title (fr)

SEMICONDUCTEUR A OXYDE METALLIQUE NANOPOREUX SPECTRALEMENT SENSIBILISE A L'AIDE DE NANOPARTICULES DE CHALCOGENURE METALLIQUE

Publication

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Application

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- EP 0350346 W 20030729
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Abstract (en)

[origin: WO2004017427A1] A nano-porous metal oxide semiconductor with a band-gap of greater than 2.9 eV in-situ spectrally sensitized on its internal and external surface with metal chalcogenide nano-particles with a band-gap of less than 2.9 eV containing at least one metal chalcogenide, characterized in that the nano-porous metal oxide further contains a phosphoric acid or a phosphate; and a process for in-situ spectral sensitization of nano-porous metal oxide semiconductor with a band-gap of greater than 2.9 eV on its internal and external surface with metal chalcogenide nanoparticles with a band-gap of less than 2.9 eV, containing at least one metal chalcogenide, comprising a metal chalcogenide-forming cycle comprising the steps of: contacting nano-porous metal oxide with a solution of metal ions; contacting nano-porous metal oxide with a solution of chalcogenide ions; and subsequent to metal chalcogenide formation rinsing the nano-porous metal oxide with an aqueous solution containing a phosphoric acid or a phosphate.

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